

**Search Notes**

Application/Control No.

09/912,184

Examiner

Hai L. Nguyen

Applicant(s)/Patent under  
Reexamination

ISHIKAWA ET AL.

Art Unit

2816

**SEARCHED**

Class	Subclass	Date	Examiner
327	50,58,62, 68-70	4/8/2005	HLN
327	77-79	4/8/2005	HLN
327	91,94	4/8/2005	HLN
341	122,123	4/8/2005	HLN

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
Search	Above	4/8/2005	HLN

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Shepardize Search	4/8/2005	HLN
EAST Text Search (zero ADJ cross) AND ("90" ADJ degree)	4/8/2005	HLN